SiGe:C low-noise amplifier MMIC for LTE

## 3. Applications

- LNA for LTE reception in smart phones
- Feature phones
- Tablet PCs
- RF front-end modules

## 4. Quick reference data

### Table 1. Quick reference data

f = 2350 MHz;  $V_{CC}$  = 2.8 V;  $V_{I(ENABLE)}$   $\geq$  0.8 V;  $T_{amb}$  = 25 °C; input matched to 50  $\Omega$  using a 3.3 nH inductor; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		1.5	-	3.1	V
I <sub>CC</sub>	supply current		3.0	5.0	7.0	mA
Gp	power gain	[1]	-	13	-	dB
NF	noise figure	[1][2][3]	-	0.9	1.5	dB
P <sub>i(1dB)</sub>	input power at 1 dB gain compression	[1][3]	-7	-3	-	dBm
IP3 <sub>i</sub>	input third-order intercept point	[1][3]	1	6	-	dBm

- [1] E-UTRA operating band 40 (2300 MHz to 2400 MHz).
- [2] PCB losses are subtracted.
- [3] Guaranteed by device design; not tested in production.

# 5. Ordering information

### Table 2. Ordering information

Type number	Package				
	Name	Description	Version		
BGU8H1	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1.1 $\times$ 0.7 $\times$ 0.37 mm	SOT1232		

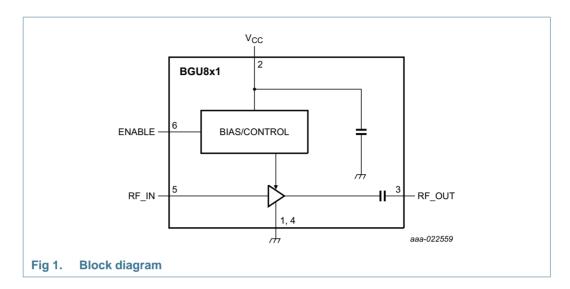
## 6. Marking

### Table 3. Marking codes

Type number	Marking code
BGU8H1	F

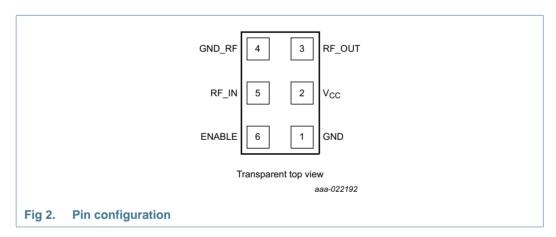
SiGe:C low-noise amplifier MMIC for LTE

## 7. Block diagram



## 8. Pinning information

## 8.1 Pinning



## 8.2 Pin description

Table 4. Pin description

Symbol	Pin	Description
GND	1	ground
V <sub>CC</sub>	2	supply voltage
RF_OUT	3	RF output
GND_RF	4	ground RF
RF_IN	5	RF input
ENABLE	6	enable

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### SiGe:C low-noise amplifier MMIC for LTE

## 9. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Absolute maximum ratings are given as limiting values of stress conditions during operation, that must not be exceeded under the worst probable conditions.

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage	RF input AC coupled	<u>[1]</u>	-0.5	+5.0	V
V <sub>I(ENABLE)</sub>	input voltage on pin ENABLE	V <sub>I(ENABLE)</sub> < V <sub>CC</sub> + 0.6 V	[1][2]	-0.5	+5.0	V
V <sub>I(RF_IN)</sub>	input voltage on pin RF_IN	DC; V <sub>I(RF_IN)</sub> < V <sub>CC</sub> + 0.6 V	[1][2]	-0.5	+5.0	V
V <sub>I(RF_OUT)</sub>	input voltage on pin RF_OUT	DC; V <sub>I(RF_OUT)</sub> < V <sub>CC</sub> + 0.6 V	[1][2][3]	-0.5	+5.0	V
Pi	input power		<u>[1]</u>	-	26	dBm
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 130  ^{\circ}C$		-	55	mW
T <sub>stg</sub>	storage temperature			-65	+150	°C
Tj	junction temperature			-	150	°C
V <sub>ESD</sub>	electrostatic discharge voltage	Human Body Model (HBM) according to ANSI/ESDA/JEDEC standard JS-001		-	±2	kV
		Charged Device Model (CDM) according to JEDEC standard JESD22-C101C		-	±1	kV

<sup>[1]</sup> Stressed with pulses of 1 s in duration. V<sub>CC</sub> connected to a power supply of 2.8 V with 500 mA current limit.

## 10. Recommended operating conditions

Table 6. Operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		1.5	-	3.1	V
T <sub>amb</sub>	ambient temperature		-40	+25	+85	°C
V <sub>I(ENABLE)</sub>	input voltage on pin ENABLE	OFF state	-	-	0.3	V
		ON state	0.8	-	-	V

## 11. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		225	K/W

<sup>[2]</sup> Warning: Due to internal ESD diode protection, to avoid excess current, the applied DC voltage must not exceed V<sub>CC</sub> + 0.6 V or 5.0 V.

<sup>[3]</sup> The RF output is AC coupled through internal DC blocking capacitors.

### SiGe:C low-noise amplifier MMIC for LTE

### 12. Characteristics

### Table 8. Characteristics at $V_{CC} = 1.8 \text{ V}$

2300 MHz  $\leq$  f  $\leq$  2690 MHz;  $V_{CC}$  = 1.8 V;  $V_{I(ENABLE)} \geq$  0.8 V;  $T_{amb}$  = 25 °C; input matched to 50  $\Omega$  using a 3.3 nH inductor; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CC</sub>	supply current	V <sub>I(ENABLE)</sub> ≥ 0.8 V		2.8	4.8	6.8	mA
		V <sub>I(ENABLE)</sub> ≤ 0.3 V		-	-	1	μА
Gp	power gain	f = 2350 MHz	<u>[1]</u>	-	13.0	-	dB
		f = 2500 MHz		10.5	12.5	14.5	dB
		f = 2655 MHz	[2]	-	12.0	-	dB
$RL_{in}$	input return loss	f = 2350 MHz	<u>[1]</u>	-	8	-	dB
		f = 2655 MHz	[2]	-	8	-	dB
RL <sub>out</sub>	output return loss	f = 2350 MHz	<u>[1]</u>	-	20	-	dB
		f = 2655 MHz	[2]	-	20	-	dB
ISL	isolation	f = 2350 MHz	<u>[1]</u>	-	20	-	dB
		f = 2655 MHz	[2]	-	20	-	dB
NF	noise figure	f = 2350 MHz	[1][3][4]	-	0.9	1.5	dB
		f = 2655 MHz	[2][3]	-	1.1	-	dB
P <sub>i(1dB)</sub>	input power at 1 dB	f = 2350 MHz	[1][4]	-12	-8	-	dBm
	gain compression	f = 2655 MHz	[2]	-	-7	-	dBm
IP3 <sub>i</sub>	input third-order intercept point	f = 2350 MHz	[1][4]	-3	+2	-	dBm
		f = 2655 MHz	[2]	-	5	-	dBm
K	Rollett stability factor			1	-	-	-
t <sub>on</sub>	turn-on time	time from $V_{I(ENABLE)}$ ON to 90 % of the gain		-	-	4	μS
t <sub>off</sub>	turn-off time	time from V <sub>I(ENABLE)</sub> OFF to 10 % of the gain		-	-	1	μS

<sup>[1]</sup> E-UTRA operating band 40 (2300 MHz to 2400 MHz).

<sup>[2]</sup> E-UTRA operating band 7 (2620 MHz to 2690 MHz).

<sup>[3]</sup> PCB losses are subtracted.

<sup>[4]</sup> Guaranteed by device design; not tested in production.

### SiGe:C low-noise amplifier MMIC for LTE

Table 9. Characteristics at  $V_{CC} = 2.8 \text{ V}$ 

2300 MHz  $\leq$  f  $\leq$  2690 MHz;  $V_{CC}$  = 2.8 V;  $V_{I(ENABLE)} \geq$  0.8 V;  $T_{amb}$  = 25 °C; input matched to 50  $\Omega$  using a 3.3 nH inductor; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CC</sub>	supply current	$V_{I(ENABLE)} \ge 0.8 \text{ V}$		3.0	5.0	7.0	mA
		$V_{I(ENABLE)} \le 0.3 \text{ V}$		-	-	1	μΑ
G <sub>p</sub>	power gain	f = 2350 MHz	<u>[1]</u>	-	13	-	dB
		f = 2500 MHz		10.8	12.8	14.8	dB
		f = 2655 MHz	[2]	-	12.5	-	dB
RLin	input return loss	f = 2350 MHz	<u>[1]</u>	-	9	-	dB
		f = 2655 MHz	[2]	-	9	-	dB
RL <sub>out</sub>	output return loss	f = 2350 MHz	<u>[1]</u>	-	20	-	dB
	f = 2655 MHz	[2]	-	20	-	dB	
ISL	isolation	f = 2350 MHz	<u>[1]</u>	-	22	-	dB
		f = 2655 MHz	[2]	-	22	-	dB
NF	noise figure	f = 2350 MHz	[1][3][4]	-	0.9	1.5	dB
		f = 2655 MHz	[2][3]	-	1.0	-	dB
P <sub>i(1dB)</sub>	input power at 1 dB	f = 2350 MHz	[1][4]	-7	-3	-	dBm
	gain compression	f = 2655 MHz	[2]	-	-1	-	dBm
IP3 <sub>i</sub>	input third-order intercept point	f = 2350 MHz	[1][4]	1	6	-	dBm
		f = 2655 MHz	[2]	-	8	-	dBm
K	Rollett stability factor			1	-	-	-
t <sub>on</sub>	turn-on time	time from V <sub>I(ENABLE)</sub> ON to 90 % of the gain		-	-	4	μS
t <sub>off</sub>	turn-off time	time from V <sub>I(ENABLE)</sub> OFF to 10 % of the gain		-	-	1	μS

<sup>[1]</sup> E-UTRA operating band 40 (2300 MHz to 2400 MHz).

<sup>[2]</sup> E-UTRA operating band 7 (2620 MHz to 2690 MHz).

<sup>[3]</sup> PCB losses are subtracted.

<sup>[4]</sup> Guaranteed by device design; not tested in production.

## 13. Package outline

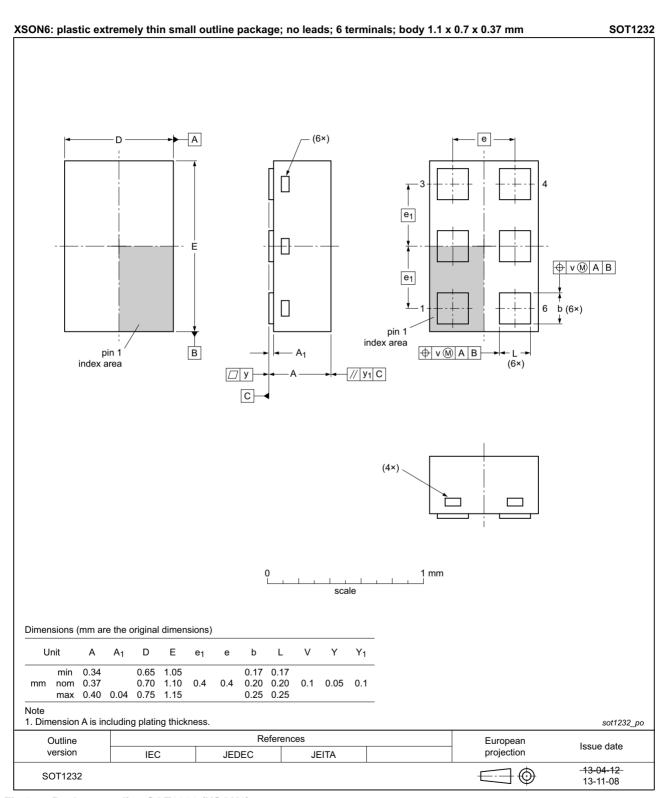


Fig 3. Package outline SOT1232 (XSON6)

### SiGe:C low-noise amplifier MMIC for LTE

## 14. Handling information

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

### 15. Abbreviations

#### Table 10. Abbreviations

Acronym	Description
ESD	ElectroStatic Discharge
E-UTRA	Evolved UMTS Terrestrial Radio Access
НВМ	Human Body Model
LNA	Low-Noise Amplifier
LTE	Long Term Evolution
MMIC	Monolithic Microwave Integrated Circuit
PCB	Printed-Circuit Board
SiGe:C	Silicon Germanium Carbon

## 16. Revision history

### Table 11. Revision history

Document ID	Release date Data sheet status Change notice		Change notice	Supersedes	
BGU8H1 v.3	20170116	Product data sheet	- BGU8ł		
Modifications:	Section 1: added LTE1001H according to our new naming convention				
BGU8H1 v.2	20160428 Product data sheet - BGU8		BGU8H1 v.1		
Modifications:	• Table 5: update	ted value input power; added	Table note [1]		
	• Table 8: update	ted G <sub>p</sub> power gain with f = 25	500 MHz; added <u>Table</u>	note [4]	
	• <u>Table 9</u> : updated G <sub>p</sub> power gain with f = 2500 MHz; added <u>Table note [4]</u>				
BGU8H1 v.1	20140603	Product data sheet -		-	

**Product data sheet** 

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#### SiGe:C low-noise amplifier MMIC for LTE

## 17. Legal information

### 17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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### SiGe:C low-noise amplifier MMIC for LTE

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